Search Notes

Application/Control No.	Applica Reexam
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Applicant(s)/Patent unde Reexamination			
ΓΔΚΔΩ	YOSHIHIRO		

10/743,438 Examiner

Art Unit 2826

Tuan Quach

	SEARCHED				
Class	Subclass	Date	Examiner		
257	758, 760, 773	5/9/2005	TQ		
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INTERFERENCE SEARCHED			
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257	758-773	5/9/2005	TQ
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